

Search Notes**Application/Control No.**

09/679,816

Examiner

Huy D. Nguyen

Applicant(s)/Patent under Reexamination

SAKAKURA, TAKASHI

Art Unit

2617

SEARCHED

Class	Subclass	Date	Examiner
455	456.1	5/29/2003	HN
	456.2		
	456.5		
	456.6		
	41.2		
	435.1		
	435.2		
	435.3		
	517		
	433		
Updated	search	12/5/2003	HN
Updated	search	5/19/2004	HN
Updated	search	9/15/2006	HN
Updated	search	3/8/2007	HN

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
455	456.1	3/8/2007	HN
	435.1		
	456.2		

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East; Text search (USPAT, US-PGPUB, JPO, EPO, DERWENT).	5/29/2003	HN
East; Text search (USPAT, US-PGPUB, JPO, EPO, DERWENT).	12/5/2003	HN
East; Text search (USPAT, US-PGPUB, JPO, EPO, DERWENT).	5/19/2004	HN
East; Text search (USPAT, US-PGPUB, JPO, EPO, DERWENT). See search history printout.	9/15/2006	HN
East; Text search (USPAT, US-PGPUB, JPO, EPO, DERWENT). See search history printout.	3/8/2007	HN
See interference search printout.	3/8/2007	HN